

Sondy pro měření EMC

SRF 5030

AMT měřicí technika, spol. s r.o.

Near Field Probe

Parameter	Model	SRF5030-1	SRF5030-2	SRF5030-3	SRF5030-4
					
Frequency Range		30 MHz to 3 GHz	30 MHz to 3 GHz	30 MHz to 2 GHz	30 MHz to 3 GHz
Resolution		25 mm	10 mm	5 mm	2 mm
Application		<p>It can be used at a distance of up to 10 cm from the units. The probe detects the spatial distribution of HF magnetic fields in devices and assemblies and allows the user to draw conclusions with regard to disturbance emissions. Frequency range: 30 MHz to 3 GHz</p>	<p>It is suitable for measurements up to 3 cm. Interference sources can be localized by detecting the distribution and orientation of the field, therefore enabling a more exact use of higher resolution probes. Frequency range: 30 MHz to 3 GHz</p>	<p>It is suitable for measurements up to 3 cm. Interference sources can be localized by detecting the distribution and orientation of the field, therefore enabling a more exact use of higher resolution probes. Frequency range: 30 MHz to 3 GHz</p>	<p>It is designed for the detection of magnetic fields which are emitted vertically from the surface of PCBs and is thus ideal for investigating current loops. The probe allows the measurement in confined board areas (between large controller components, for example - resolution approx. 2 mm). Frequency range: 30 MHz to 3 GHz</p>